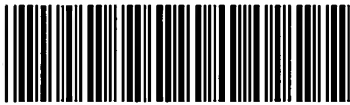


Search Notes

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10/705,620

Examiner

Phillip Nguyen

Applicant(s)/Patent under
Reexamination

FREEMAN ET AL.

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US 20030005706 US 5181214	10/23/2006	SA